

# **AUIRF6215STRL Datasheet**



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DiGi Electronics Part Number AUIRF6215STRL-DG

Manufacturer Infineon Technologies

Manufacturer Product Number AUIRF6215STRL

Description MOSFET P-CH 150V 13A D2PAK

Detailed Description P-Channel 150 V 13A (Tc) 3.8W (Ta), 110W (Tc) Surf

ace Mount D2PAK



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## **Purchase and inquiry**

Manufacturer Product Number:	Manufacturer:
AUIRF6215STRL	Infineon Technologies
Series:	Product Status:
HEXFET®	Last Time Buy
FET Type:	Technology:
P-Channel	MOSFET (Metal Oxide)
Drain to Source Voltage (Vdss):	Current - Continuous Drain (Id) @ 25°C:
150 V	13A (Tc)
Drive Voltage (Max Rds On, Min Rds On):	Rds On (Max) @ ld, Vgs:
10V	290mOhm @ 6.6A, 10V
Vgs(th) (Max) @ ld:	Gate Charge (Qg) (Max) @ Vgs:
4V @ 250μA	66 nC @ 10 V
Vgs (Max):	Input Capacitance (Ciss) (Max) @ Vds:
±20V	860 pF @ 25 V
FET Feature:	Power Dissipation (Max):
	3.8W (Ta), 110W (Tc)
Operating Temperature:	Mounting Type:
-55°C ~ 175°C (TJ)	Surface Mount
Supplier Device Package:	Package / Case:
D2PAK	TO-263-3, D2PAK (2 Leads + Tab), TO-263AB
Base Product Number:	
AUIRF6215	

# **Environmental & Export classification**

8541.29.0095

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	

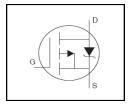


### **AUTOMOTIVE GRADE**

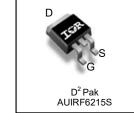
### AUIRF6215S

#### **Features**

- Advanced Planar Technology
- Low On-Resistance
- P-Channel MOSFET
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- · Fully Avalanche Rated
- · Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>	-150V
R <sub>DS(on)</sub> max.	0.29Ω
I <sub>D</sub>	-13A



G	D	S
Gate	Drain	Source

### Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

Page part number	Pookogo Typo	Standard Pack		Orderable Part Number	
Base part number	Package Type	Form		Orderable Part Number	
ALUDECO4EC	5S D²-Pak	Tube	50	AUIRF6215S	
AUIRF6215S	D -Pak	Tape and Reel Left	800	AUIRF6215STRL	

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V	-13	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V	-9.0	A
I <sub>DM</sub>	Pulsed Drain Current ①	-44	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Maximum Power Dissipation	3.8	10/
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	110	W
	Linear Derating Factor	0.71	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ②	310	mJ
I <sub>AR</sub>	Avalanche Current ①	-6.6	А
E <sub>AR</sub>	Repetitive Avalanche Energy ①	11	mJ
dv/dt	Peak Diode Recovery ③	-5.0	V/ns
TJ	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case®		1.4	°C 111
$R_{\theta JA}$	Junction-to-Ambient ( PCB Mount, steady state) ©		40	°C/W

HEXFET® is a registered trademark of Infineon.

<sup>\*</sup>Qualification standards can be found at www.infineon.com



### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-150			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.20		V/°C	Reference to 25°C, I <sub>D</sub> = -1mA
D	Static Drain-to-Source On-Resistance			0.29		V <sub>GS</sub> = -10V, I <sub>D</sub> = -6.6A ④
$R_{DS(on)}$	Static Diam-to-Source On-Resistance			0.58	Ω	$V_{GS} = -10V, I_D = -6.6A, T_J = 150^{\circ}C$ ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}$ , $I_D = -250\mu A$
g <sub>fs</sub>	Forward Trans conductance	3.6			S	$V_{DS} = -25V, I_{D} = -6.6A$
ı	Drain-to-Source Leakage Current			-25		$V_{DS} = -150V, V_{GS} = 0V$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			-250	μA	$V_{DS} = -120V, V_{GS} = 0V, T_{J} = 150$ °C
$I_{GSS}$	Gate-to-Source Forward Leakage			-100	nΛ	$V_{GS} = -20V$
	Gate-to-Source Reverse Leakage			100	nA	V <sub>GS</sub> = 20V

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Q <sub>q</sub>	Total Gate Charge	 	66		$I_D = -6.6A$
$Q_{gs}$	Gate-to-Source Charge	 	8.1	4	V <sub>DS</sub> = -120V
$Q_{gd}$	Gate-to-Drain Charge	 	35		V <sub>GS</sub> = -10V4
$t_{d(on)}$	Turn-On Delay Time	 14			V <sub>DD</sub> = -75V
t <sub>r</sub>	Rise Time	 36		no	$I_D = -6.6A$
$t_{d(off)}$	Turn-Off Delay Time	 53		ns	$R_G = 6.8\Omega$ ,
t <sub>f</sub>	Fall Time	 37			R <sub>D</sub> = 12Ω ④
Ls	Internal Source Inductance	 7.5			Between lead,6mm (0.25in.) from package and center of die contact
C <sub>iss</sub>	Input Capacitance	 860			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance	 220		pF	$V_{DS} = -25V$
C <sub>rss</sub>	Reverse Transfer Capacitance	 130			f = 1.0MHz, See Fig.5

### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions	
Is	Continuous Source Current (Body Diode)			-11	_	MOSFET symbol showing the	
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			-44		integral reverse p-n junction diode.	
$V_{SD}$	Diode Forward Voltage			-1.6	V	$T_J = 25^{\circ}C, I_S = -6.6A, V_{GS} = 0V $ ④	
t <sub>rr</sub>	Reverse Recovery Time		160	240	ns	$T_J = 25^{\circ}\text{C}, I_F = -6.6\text{A}$	
Q <sub>rr</sub>	Reverse Recovery Charge		1.2	1.7	μC	di/dt = 100A/µs ④	
t <sub>on</sub>	Forward Turn-On Time	Intrins	c turn-c	on time	is neglig	gible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )	

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)
- $\label{eq:loss_def} \ensuremath{\Im} \quad I_{SD} \leq \text{-}6.6A, \ di/dt \leq 620A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .
- S When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994



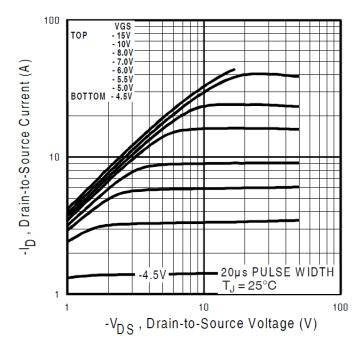


Fig. 1 Typical Output Characteristics

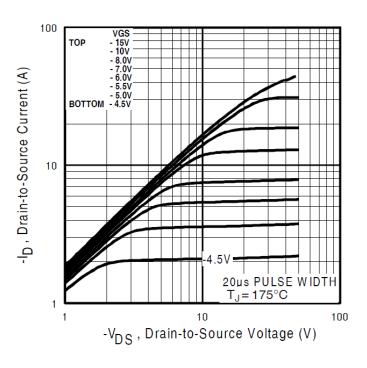


Fig. 2 Typical Output Characteristics

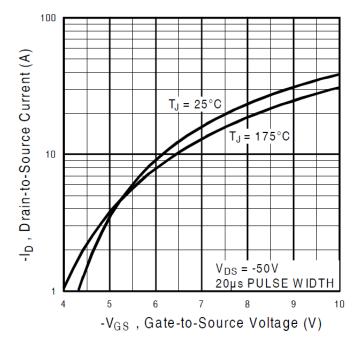
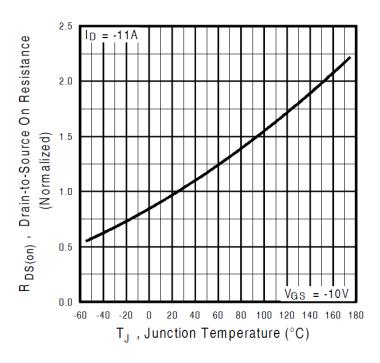
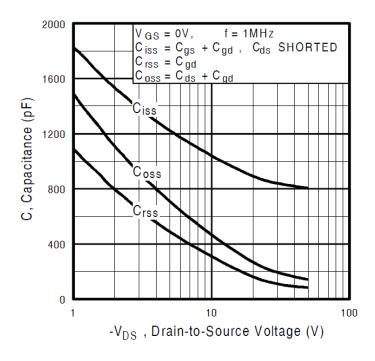


Fig. 3 Typical Transfer Characteristics



**Fig. 4** Normalized On-Resistance vs. Temperature





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Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

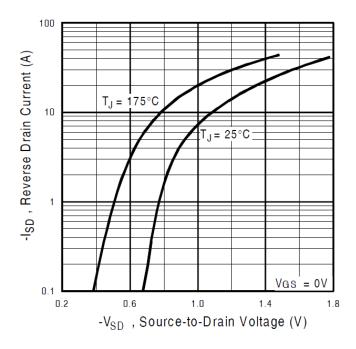


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

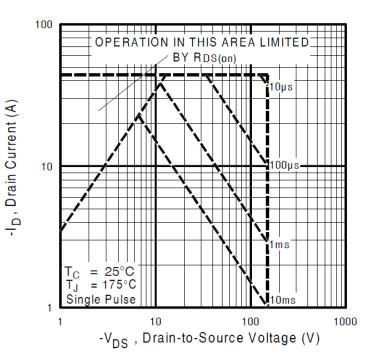


Fig 8. Maximum Safe Operating Area

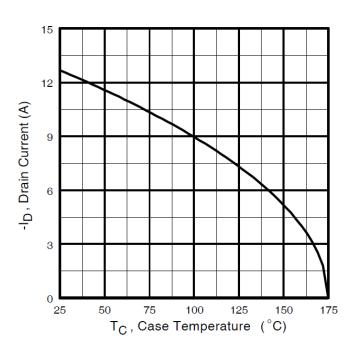


Fig 9. Maximum Drain Current vs.
Case Temperature

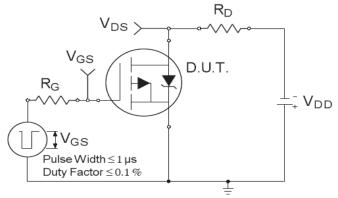


Fig 10a. Switching Time Test Circuit

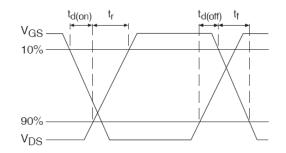


Fig 10b. Switching Time Waveforms

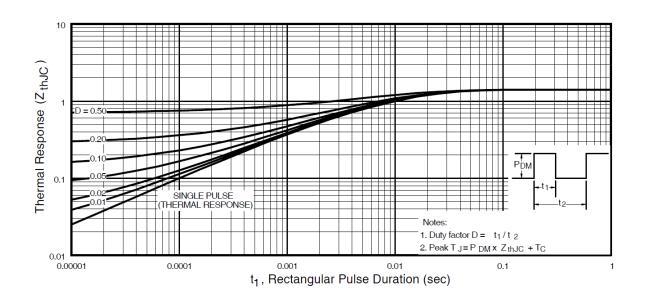


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



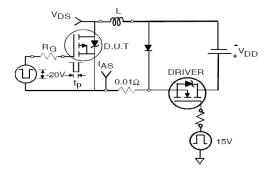


Fig 12a. Unclamped Inductive Test Circuit

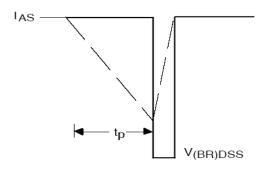


Fig 12c. Maximum Avalanche Energy vs. Drain Current

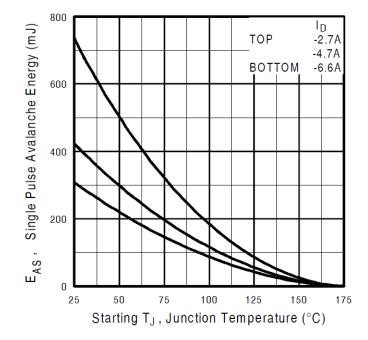
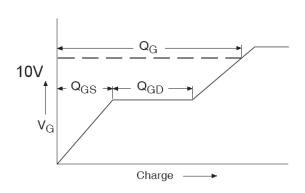


Fig 12b. Unclamped Inductive Waveforms



Current Regulator

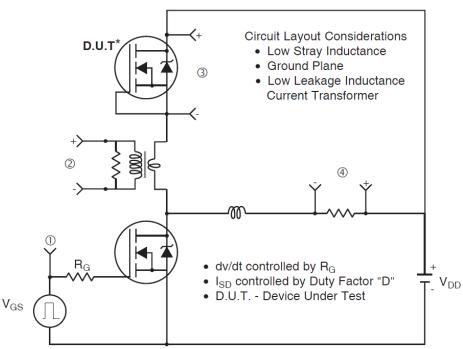
Same Type as D.U.T.  $V_{GS}$   $J_{G}$   $J_{G}$ Current Sampling Resistors

Fig 13b. Gate Charge Test Circuit

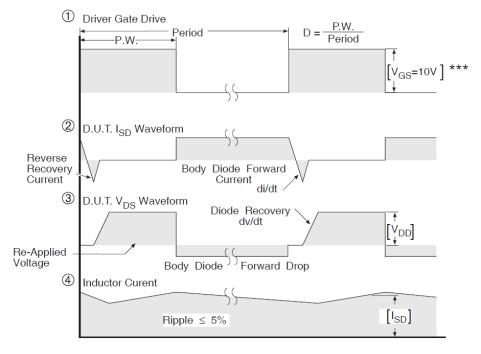
Fig 13a. Gate Charge Waveform



### Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity of D.U.T for P-Channel

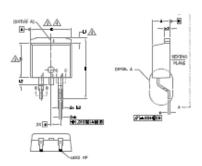


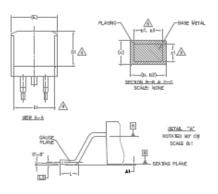
\*\*\*  $V_{GS}$  = 5.0V for Logic Level and 3V Drive Devices

Fig 14. Peak Diode Recovery dv/dt Test Circuit for P-Channel HEXFET® Power



### D<sup>2</sup> - Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASIVE Y14.5W-1994
- 2. DIVENSIONS ARE SHOWN IN WILLIWETERS [INCHES].

3 DIVENSION D & E DO NOT INCLUDE WOLD FLASH, WOLD FLASH SHALL NOT EXCEED 0.127 [.006\*] PER SIDE THESE DIMENSIONS ARE MEASURED AT THE OUTWOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

B DIMENSION 61, 63 AND €1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y M	DIMENSIONS							
B	MILLIM	ETERS	INC	INCHES				
BOL	MIN.	MAX.	MIN.	MAX.	OT ES			
Α	4.06	4.83	.160	.190				
A1	0.00	0.254	.000	.010				
Ь	0.51	0.99	.020	.039				
b1	0.51	0.89	.020	.035	5			
b2	1.14	1.78	.045	.070				
Ь3	1.14	1.73	.045	.068	5			
С	0.38	0.74	.015	.029				
c1	0.38	0.58	.015	.023	5			
c2	1.14	1.65	.045	.065				
D	8.38	9.65	.330	.380	3			
D1	6.86	_	.270	_	4			
Ε	9.65	10.67	.380	.420	3,4			
E1	6.22	_	.245	_	4			
e	2.54	BSC	.100	BSC				
Н	14.61	15.88	.575	.625				
L	1.78	2.79	.070	.110				
L1	_	1.68	-	.066	4			
L2	_	1.78	-	.070				
L3	0.25	BSC	.010	BSC				

#### LEAD ASSIGNIVENTS

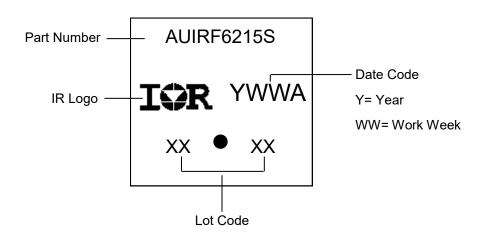
### DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE

HEXFET 1.— GATE 2. 4.— DRAIN 3.— SOURCE

GBTs, CoPACK 1,— GATE 2, 4.— COLLECTOR 3.— EVITTER

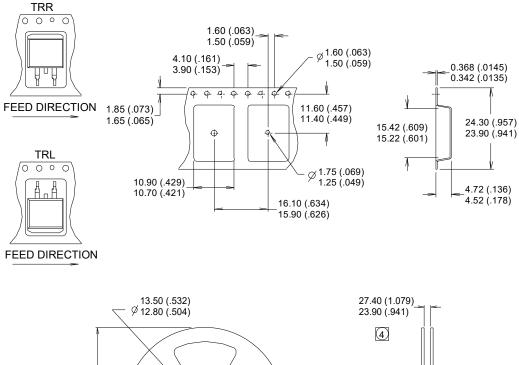
### D<sup>2</sup>- Pak (TO-263AB) Part Marking Information

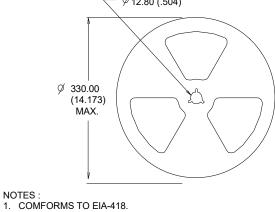


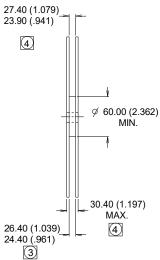
Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/packaging">http://www.irf.com/packaging</a>



### D<sup>2</sup>- Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at http://www.irf.com/packaging



### **Qualification Information**

Qualification Level		Automotive (per AEC-Q101)	
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
Moisture Sensitivity Level		D <sup>2</sup> -Pak	MSL1
ESD	Machine Model		Class M3 (+/- 400V) <sup>†</sup>
			AEC-Q101-002
	Human Body Model	Class H1B (+/- 1000V) <sup>†</sup>	
		AEC-Q101-001	
	Charged Device Model	Class C5 (+/- 1125V) <sup>†</sup>	
		AEC-Q101-005	
RoHS Compliant		Yes	

<sup>†</sup> Highest passing voltage.

### **Revision History**

Date	Rev.	Comments		
11/13/2015	2.1	<ul> <li>Updated datasheet with corporate template</li> <li>Corrected ordering table on page 1.</li> </ul>		
10/10/2017	2.2	Corrected typo error on part marking on page 8.		
12/16/2020	2.3	<ul> <li>Correct footer date (inconsistent date) on all pages</li> <li>Removed "HEXFET® Power MOSFET" -page1</li> </ul>		

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